



#### 100V N-CHANNEL ENHANCEMENT MODE MOSFET

### **Product Summary**

| BV <sub>DSS</sub> | R <sub>DS(ON)</sub> Max               | I <sub>D</sub> Max<br>T <sub>A</sub> = +25°C |  |  |
|-------------------|---------------------------------------|--|--|--|
| 400\/             | $23m\Omega$ @ V <sub>GS</sub> = $10V$ | 7.4A   |  |  |
| 100V              | 30mΩ @ V <sub>GS</sub> = 6V           | 6.5A   |  |  |

### **Description and Applications**

This MOSFET is designed to minimize the on-state resistance ( $R_{DS(ON)}$ ), yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- High Frequency Switching
- Synchronous Rectification
- DC-DC Converters

#### **Features and Benefits**

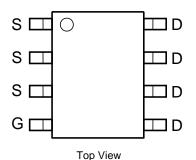
- 100% Unclamped Inductive Switching Ensures More Reliable and Robust End Application
- High Conversion Efficiency
- Low R<sub>DS(ON)</sub> Minimizes On-State Losses
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative.

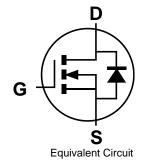
https://www.diodes.com/quality/product-definitions/

#### **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 3 per J-STD-020
- Terminal Finish Matte Tin Annealed over Copper Leadframe.
   Solderable per MIL-STD-202, Method 208 ©3
- Weight: 0.074 grams (Approximate)







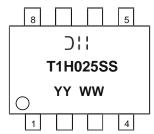
#### **Ordering Information** (Note 4)

| Part Number     | Case | Packaging         |
|-----------------|------|-------------------|
| DMT10H025SSS-13 | SO-8 | 2,500/Tape & Reel |

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/

### **Marking Information**



⊃¦¦ = Manufacturer's Marking T1H025SS = Product Type Marking Code YYWW = Date Code Marking YY or YY = Year (ex: 19 = 2019) WW = Week (01 to 53)



## **Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

| Characteristic   | Symbol          | Value | Unit       |   |
|--|-----------------|-------|------------|---|
| Drain-Source Voltage   | VDSS            | 100   | V          |   |
| Gate-Source Voltage  | Vgss            | ±20   | V          |   |
| Continuous Drain Current (Note 6) $V_{GS} = 10V$ $T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$ |                 | lo    | 7.4<br>5.9 | А |
| Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)   | I <sub>DM</sub> | 45    | Α          |   |
| Maximum Continuous Body Diode Forward Current (Note 6)                                     | ls              | 3.2   | Α          |   |
| Pulsed Body Diode Forward Current (10µs Pulse, Duty Cycle                                  | Ism             | 45    | Α          |   |
| Avalanche Current, L = 0.1mH   | las             | 25    | Α          |   |
| Avalanche Energy, L = 0.1mH  | Eas             | 31.25 | mJ         |   |

# Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

| Characteristic                                   | Symbol                           | Value       | Unit |   |
|--|----------------------------------|-------------|------|---|
| Total Power Dissipation (Note 5)                 | $T_A = +25$ °C                   | PD          | 1.4  | W |
| Thermal Resistance, Junction to Ambient (Note 5) | RθJA                             | 91          | °C/W |   |
| Total Power Dissipation (Note 6)                 | PD                               | 1.9         | W    |   |
| Thermal Resistance, Junction to Ambient (Note 6) | $R_{\theta JA}$                  | 65          | °C/W |   |
| Total Power Dissipation (Note 6)                 | $T_C = +25^{\circ}C$             | PD          | 12.9 | W |
| Thermal Resistance, Junction to Case (Note 6)    | Rejc                             | 8.5         | °C/W |   |
| Operating and Storage Temperature Range          | T <sub>J,</sub> T <sub>STG</sub> | -55 to +150 | °C   |   |

## **Electrical Characteristics** (T<sub>A</sub> = +25°C, unless otherwise specified.)

| Characteristic                           | Symbol              | Min | Тур  | Max  | Unit | Test Condition  |  |
|--|---------------------|-----|------|------|------|---|--|
| OFF CHARACTERISTICS (Note 7)             |                     |     |      |      |      |   |  |
| Drain-Source Breakdown Voltage           | BVDSS               | 100 | l    | _    | ٧    | $V_{GS} = 0V$ , $I_D = 1mA$                                   |  |
| Zero Gate Voltage Drain Current          | I <sub>DSS</sub>    |     |      | 1    | μA   | $V_{DS} = 80V, V_{GS} = 0V$                                   |  |
| Gate-Source Leakage                      | Igss                |     | _    | ±100 | nA   | $V_{GS} = \pm 20V$ , $V_{DS} = 0V$                            |  |
| ON CHARACTERISTICS (Note 7)              |                     |     |      |      |      |   |  |
| Gate Threshold Voltage                   | V <sub>GS(TH)</sub> | 2   | _    | 4    | V    | $V_{DS} = V_{GS}$ , $I_D = 250\mu A$                          |  |
| Static Paris Course On Registeres        | _                   | _   | 17   | 23   | m0   | V <sub>GS</sub> = 10V, I <sub>D</sub> = 20A                   |  |
| Static Drain-Source On-Resistance        | R <sub>DS(ON)</sub> | _   | 22   | 30   | mΩ   | Vgs = 6V, ID = 12.5A  |  |
| Diode Forward Voltage                    | VsD                 | _   | 0.9  | 1.2  | V    | V <sub>G</sub> S = 0V, I <sub>S</sub> = 20A                   |  |
| DYNAMIC CHARACTERISTICS (Note 8)         |                     |     |      |      |      |   |  |
| Input Capacitance                        | Ciss                | l   | 1544 | _    |      |   |  |
| Output Capacitance                       | Coss                | -   | 250  | _    | pF   | $V_{DS} = 50V, V_{GS} = 0V, f = 1MHz$                         |  |
| Reverse Transfer Capacitance             | Crss                |     | 20.4 | _    |      |   |  |
| Gate Resistance                          | Rg                  | l   | 1.26 |      | Ω    | $V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$                    |  |
| Total Gate Charge (VGS = 10V)            | Qg                  | -   | 21.4 | _    |      |   |  |
| Total Gate Charge (V <sub>GS</sub> = 6V) | Qg                  | 1   | 13.4 |      | nC   | V <sub>DD</sub> = 50V, I <sub>D</sub> = 20A                   |  |
| Gate-Source Charge                       | Qgs                 | l   | 4.6  |      | 110  |   |  |
| Gate-Drain Charge                        | $Q_{gd}$            |     | 6.0  | _    |      |   |  |
| Turn-On Delay Time                       | tD(ON)              | _   | 8.2  | _    |      | $V_{DD} = 50V, V_{GS} = 10V,$ $I_{D} = 20A, R_{g} = 11\Omega$ |  |
| Turn-On Rise Time                        | t <sub>R</sub>      | _   | 11.2 | _    | no   |   |  |
| Turn-Off Delay Time                      | t <sub>D(OFF)</sub> | _   | 27.5 | _    | ns   |   |  |
| Turn-Off Fall Time                       | tF                  | _   | 13.7 | _    |      |   |  |
| Body Diode Reverse Recovery Time         | t <sub>RR</sub>     | _   | 37.5 | _    | ns   | I= - 20A di/dt - 100A/us                                      |  |
| Body Diode Reverse Recovery Charge       | Qrr                 | _   | 50.9 | _    | nC   | $I_F = 20A$ , di/dt = 100A/ $\mu$ s                           |  |

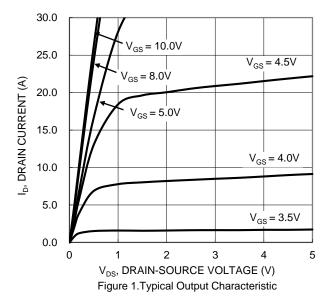
 Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate. Notes:

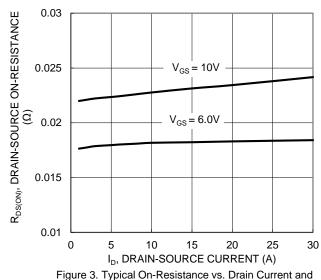
7. Short duration pulse test used to minimize self-heating effect.

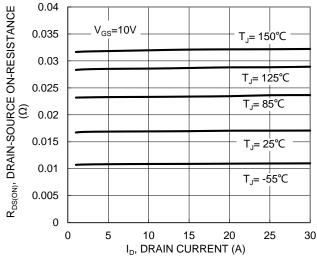
8. Guaranteed by design. Not subject to product testing.











Gate Voltage

Figure 5. Typical On-Resistance vs. Drain Current and Temperature

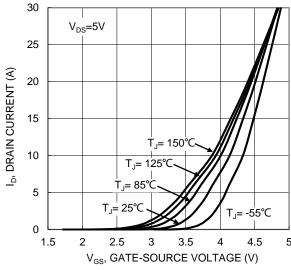


Figure 2. Typical Transfer Characteristic

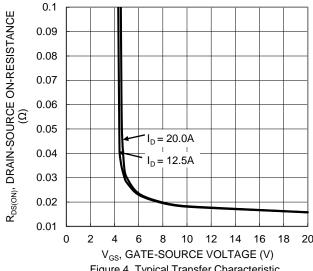


Figure 4. Typical Transfer Characteristic

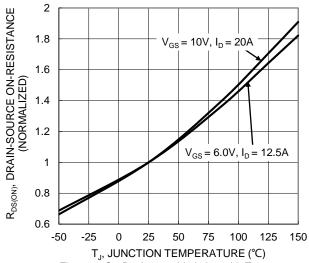


Figure 6. On-Resistance Variation with Temperature





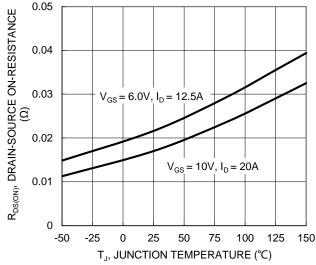
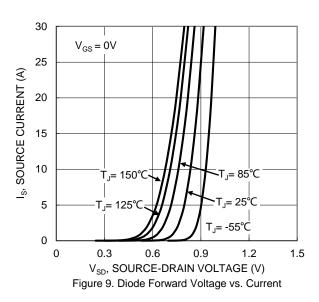


Figure 7. On-Resistance Variation with Temperature



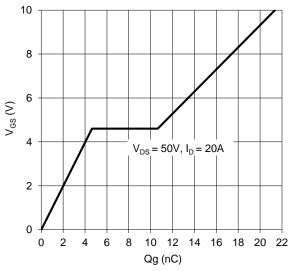


Figure 11. Gate Charge

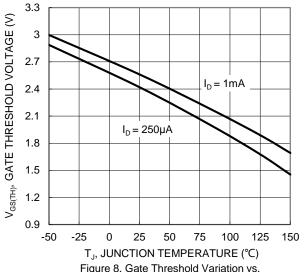
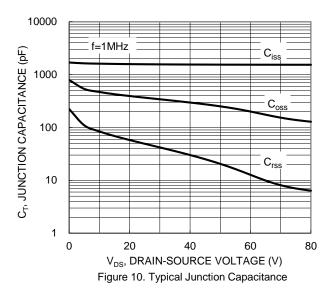
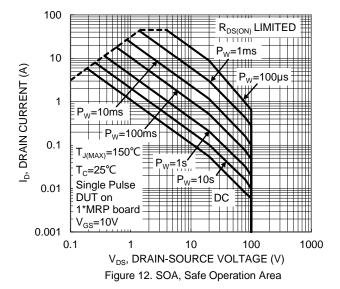


Figure 8. Gate Threshold Variation vs. JunctionTemperature







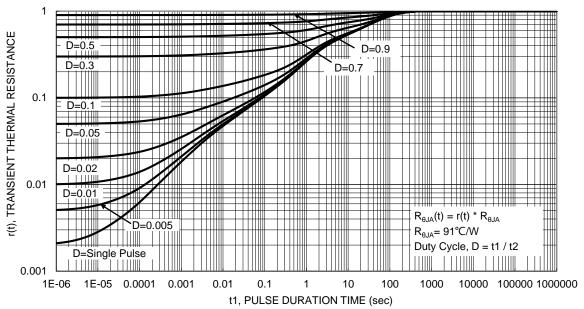


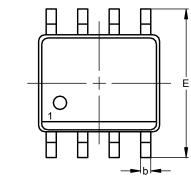
Figure 13. Transient Thermal Resistance

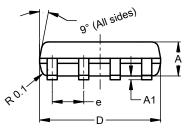


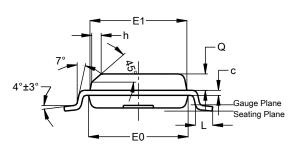
## **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.







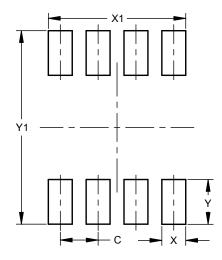


| SO-8                 |      |      |      |  |  |  |
|----------------------|------|------|------|--|--|--|
| Dim                  | Min  | Max  | Тур  |  |  |  |
| Α                    | 1.40 | 1.50 | 1.45 |  |  |  |
| A1                   | 0.10 | 0.20 | 0.15 |  |  |  |
| b                    | 0.30 | 0.50 | 0.40 |  |  |  |
| С                    | 0.15 | 0.25 | 0.20 |  |  |  |
| D                    | 4.85 | 4.95 | 4.90 |  |  |  |
| Е                    | 5.90 | 6.10 | 6.00 |  |  |  |
| E1                   | 3.80 | 3.90 | 3.85 |  |  |  |
| E0                   | 3.85 | 3.95 | 3.90 |  |  |  |
| e 1.27               |      |      |      |  |  |  |
| h                    |      |      | 0.35 |  |  |  |
| L                    | 0.62 | 0.82 | 0.72 |  |  |  |
| Q                    | 0.60 | 0.70 | 0.65 |  |  |  |
| All Dimensions in mm |      |      |      |  |  |  |

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

**SO-8** 



| Dimensions | Value (in mm) |  |  |  |
|------------|---------------|--|--|--|
| С          | 1.27          |  |  |  |
| Х          | 0.802         |  |  |  |
| X1         | 4.612         |  |  |  |
| Υ          | 1.505         |  |  |  |
| Y1         | 6.50          |  |  |  |



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